

Application/Control No.	Applicant(s)/Patent under Reexamination	atent under 1	
10/815,302	LIU ET AL.		
Examiner	Art Unit		
Anton B. Harris	2831		

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	SEARCHED			
Class	Subclass	Date	Examiner	
174	50,66	Celizlos	ABA	
	50.51			
361	687,679			
	480,681			
248	977			
	923			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
USPATZUS-PGPUREPO JPOJIJERWANT	blistor	A2#		
See EASF Test Search	1	1		